



IECQ QUALITY ASSESSMENT SYSTEM (IECQ)

For rules and details of the IECQ visit www.iecq.org

IECQ Certificate of Approval Independent Testing Laboratory

IECQ Certificate No.:	IECQ-L ULTW 16.0003-07	Issue No.:	8	Status:	Current
Additional Site to Certification: IECQ-L ULTW 16.0003		Originally Issued: 2016/07/28			
Supersedes:	IECQ-L ULTW 16.0003-07 Issue 7	Issue Date:	2025/06/29	Site Added:	2016/07/28
CB Reference No.:	50600097 ITL	Expiration:	2028/07/27		

Materials Analysis Technology Inc.

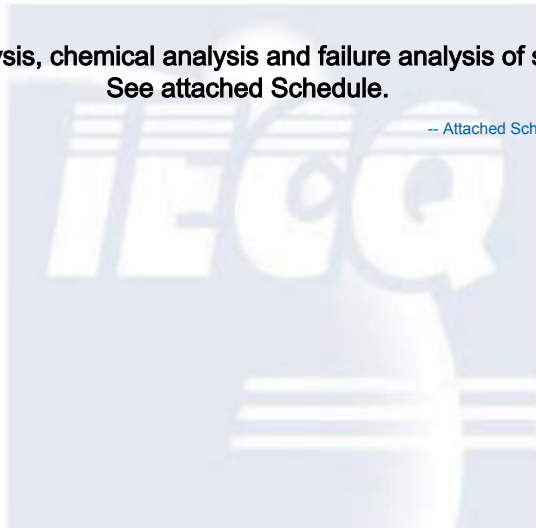
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Xinshi Dist., Tainan City 744
Taiwan

The organization, facilities and procedures have been assessed by the IECQ Certification Body in accordance with IECQ 03-1 and IECQ 03-6 for issuance of this certificate and found to be in conformity with the applicable requirements of the IECQ Independent Testing Laboratory Assessment Program Requirements Scheme and in respect of ISO/IEC 17025:2017 for the testing of component product under the IECQ.

Scope:

The materials analysis, chemical analysis and failure analysis of semiconductors.
See attached Schedule.

-- Attached Schedule: IECQ-L_ULTW_50600097 ITL_06-29-25.pdf --



Approved by Certification Body (CB): DQS Group - DQS Taiwan Inc.

8F, 23, Yuan Huan West Road,
Feng Yuan Dist., Taichung City
Taiwan

Authorized person:
Bob CHEN



The validity of this certificate is maintained through on-going surveillance audits by the IECQ CB issuing this certificate.
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**Schedule of Scope to Certificate of Approval
Independent Testing Laboratory**

IECQ Certificate No.: IECQ-L ULTW 16.0003-07

CB Certificate No.: 50600097 ITL

Schedule Number: IECQ-L ULTW 16.0003-07-S Rev No.: 8 Revision Date: 2025/06/29 Page 1 of 1

**Appendix-1 (50600097 ITL)
Schedule of Scope to Certificate of Approval**

Description test	Standard
Scanning Electron Microscope (SEM)	T-SEM-3
Transmission Electron Microscope (TEM)	T-TEM-3
Focused Ion Beam microscope (FIB)	T-FIB-3
Emission Microscopy (EMMI)-InGaAs	T-EFA-3
Optical Microscope (OM)	T-OMI-3
IC Layout Imaging	T-OMI-3
Decapsulation- Chemical	T-LAB-3
Delayer	T-LAB-3
Thermal Emission Microscope (THEMOS)	T-EFA-3
Energy Dispersive Spectrometry of X-ray (EDS)	T-SEM-3, T-TEM-3
3D Optical Microscope (3D OM)	T-LAB-3

Paul Yang

Technical Reviewer of DQS: _____ Date: 6/29/2025

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